

Product Summary

MOSFET		
BV_{DSS}	R_{Ds(on)} Max	I_D
-20V	85mΩ @ V _{GS} = -10V	-3.3A
	125mΩ @ V _{GS} = -4.5V	-2.8A
SCHOTTKY DIODE		
V_R	V_F Max	I_O
20V	400mV @ I _F = 0.5A	1.0A
	470mV @ I _F = 1.0A	

Description

This new generation MOSFET is designed to minimize the on-state resistance (R_{Ds(ON)}) yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

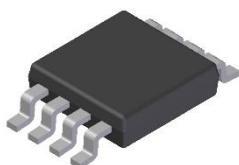
- DC-DC Converters
- Power Management Functions
- Backlighting

Features and Benefits

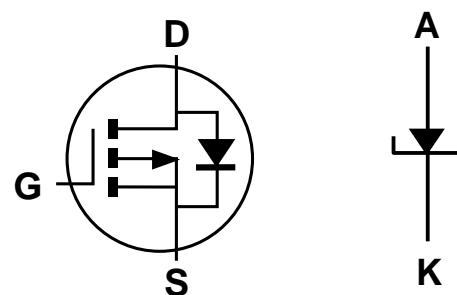
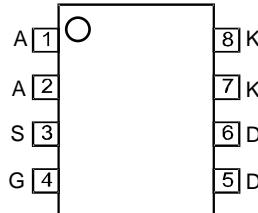
- Low Input Capacitance
- MOSFET with Low R_{Ds(ON)} – Minimize Conduction Losses
- Schottky Diode with Low Forward Voltage Drop
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)**
- Halogen and Antimony Free. "Green" Device (Note 3)
- For automotive applications requiring specific change control (i.e.: parts qualified to AEC-Q100/101/200, PPAP capable, and manufactured in IATF 16949 certified facilities), please refer to the related automotive grade (Q-suffix) part. A listing can be found at
<https://www.diodes.com/products/automotive/automotive-products/>.
- This part is qualified to JEDEC standards (as references in AEC-Q) for High Reliability.
<https://www.diodes.com/quality/product-definitions/>

Mechanical Data

- Package: SO-8
- Package Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish – Matte Tin Annealed over Copper Leadframe Solderable per MIL-STD-202, Method 208 (e3)
- Weight: 0.074 grams (Approximate)



Top View



Q1 P-Channel MOSFET

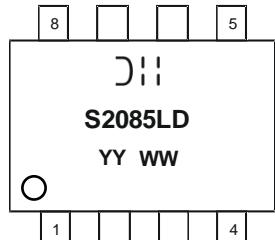
D1 Schottky Diode

Ordering Information (Note 4)

Part Number	Package	Packing	
		Qty.	Carrier
DMS2085LSD-13	SO-8	2,500	Tape & Reel

- Notes:
- No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
 - See <https://www.diodes.com/quality/lead-free/> for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
 - Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
 - For packaging details, go to our website at <https://www.diodes.com/design/support/packaging/diodes-packaging/>.

Marking Information



DII = Manufacturer's Marking
 S2085LD = Product Type Marking Code
 YYWW = Date Code Marking
 YY or YY = Year (ex: 21 = 2021)
 WW = Week (01 to 53)

Maximum Ratings – P-CHANNEL MOSFET – Q1 (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

Characteristic	Symbol	Value	Units		
Drain-Source Voltage	V_{DSS}	-20	V		
Gate-Source Voltage	V_{GSS}	± 20	V		
Continuous Drain Current (Note 6) $V_{GS} = 10\text{V}$	Steady State	$T_A = +25^\circ\text{C}$ $T_A = +70^\circ\text{C}$	I_D	-3.3 -2.7	A
	$t < 10\text{s}$	$T_A = +25^\circ\text{C}$ $T_A = +70^\circ\text{C}$	I_D	-4.3 -3.4	A
Maximum Body Diode Forward Current (Note 6)	I_S	-1.5	A		
Pulsed Drain Current (10 μs Pulse, Duty Cycle = 1%)	I_{DM}	-11.2	A		
Avalanche Current (Note 7) $L = 0.1\text{mH}$	I_{AS}	-12	A		
Avalanche Energy (Note 7) $L = 0.1\text{mH}$	E_{AS}	7	mJ		

Maximum Ratings – SCHOTTKY – D1 (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Peak Repetitive Reverse Voltage	V_{RRM}		
Working Peak Reverse Voltage	V_{RWM}	20	V
DC Blocking Voltage	V_R		
Average Rectified Output Current (Note 7, $t < 10\text{s}$)	I_O	1	A
Peak Repetitive Forward Current (Note 7, $t < 10\text{s}$)	I_{FRM}	2	A
Non-Repetitive Peak Forward Surge Current (Note 7, $t < 10\text{s}$)	I_{FSM}	20	A
Single Half Sine-Wave Superimposed on Rated Load			

Thermal Characteristics (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

Characteristic	Symbol	Value	Units
Total Power Dissipation (Note 5)	P_D	1.1	W
		0.7	
Thermal Resistance, Junction to Ambient (Note 5)	$R_{\theta JA}$	108	$^\circ\text{C}/\text{W}$
		65	
Total Power Dissipation (Note 6)	P_D	1.8	W
		1.0	
Thermal Resistance, Junction to Ambient (Note 6)	$R_{\theta JA}$	78	$^\circ\text{C}/\text{W}$
		50	
Thermal Resistance, Junction to Case (Note 6)	$R_{\theta JC}$	22	
Operating and Storage Temperature Range	T_J, T_{STG}	-55 to +150	$^\circ\text{C}$

Notes: 5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

7. I_{AS} and E_{AS} ratings are based on low frequency and duty cycles to keep $T_J = +25^\circ\text{C}$.

Electrical Characteristics P-Channel Q1 (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Drain-Source Breakdown Voltage	BV_{DSS}	-20	—	—	V	$\text{V}_{\text{GS}} = 0\text{V}$, $\text{I}_D = -250\mu\text{A}$
Zero Gate Voltage Drain Current	I_{DSS}	—	—	-1	μA	$\text{V}_{\text{DS}} = -20\text{V}$, $\text{V}_{\text{GS}} = 0\text{V}$
Gate-Source Leakage	I_{GSS}	—	—	± 100	nA	$\text{V}_{\text{GS}} = \pm 20\text{V}$, $\text{V}_{\text{DS}} = 0\text{V}$
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	$\text{V}_{\text{GS}(\text{th})}$	-0.5	-1.5	-2.2	V	$\text{V}_{\text{DS}} = \text{V}_{\text{GS}}$, $\text{I}_D = -250\mu\text{A}$
Static Drain-Source On-Resistance	$\text{R}_{\text{DS}(\text{ON})}$	—	70	85	$\text{m}\Omega$	$\text{V}_{\text{GS}} = -10\text{V}$, $\text{I}_D = -3.05\text{A}$
		—	100	125		$\text{V}_{\text{GS}} = -4.5\text{V}$, $\text{I}_D = -1.50\text{A}$
Diode Forward Voltage	V_{SD}	—	-0.8	-1.0	V	$\text{V}_{\text{GS}} = 0\text{V}$, $\text{I}_S = -1.0\text{A}$
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C_{iss}	—	353	—	pF	$\text{V}_{\text{DS}} = -15\text{V}$, $\text{V}_{\text{GS}} = 0\text{V}$ $f = 1.0\text{MHz}$
Output Capacitance	C_{oss}	—	49	—		
Reverse Transfer Capacitance	C_{rss}	—	41	—		
Gate Resistance	R_{G}	—	6.2	—	Ω	$\text{V}_{\text{DS}} = 0\text{V}$, $\text{V}_{\text{GS}} = 0\text{V}$, $f = 1.0\text{MHz}$
Total Gate Charge ($\text{V}_{\text{GS}} = -4.5\text{V}$)	Q_{g}	—	3.7	—	nC	$\text{V}_{\text{DS}} = -15\text{V}$, $\text{I}_D = -3\text{A}$
Total Gate Charge ($\text{V}_{\text{GS}} = -10\text{V}$)	Q_{g}	—	7.8	—		
Gate-Source Charge	Q_{gs}	—	1.1	—		
Gate-Drain Charge	Q_{gd}	—	1.3	—		
Turn-On Delay Time	$\text{t}_{\text{D}(\text{on})}$	—	3.3	—	ns	$\text{V}_{\text{DS}} = -15\text{V}$, $\text{R}_{\text{L}} = 15\Omega$ $\text{V}_{\text{GS}} = -10\text{V}$, $\text{R}_{\text{G}} = 6\Omega$
Turn-On Rise Time	t_{r}	—	3.0	—		
Turn-Off Delay Time	$\text{t}_{\text{D}(\text{off})}$	—	14	—		
Turn-Off Fall Time	t_{f}	—	6.8	—		
Body Diode Reverse Recovery Time	t_{rr}	—	33	—	ns	$\text{I}_S = -3.05\text{A}$, $d\text{I}/dt = 100\text{A}/\mu\text{s}$
Body Diode Reverse Recovery Charge	Q_{rr}	—	46	—	nC	$\text{I}_S = -3.05\text{A}$, $d\text{I}/dt = 100\text{A}/\mu\text{s}$

Notes: 8. Short duration pulse test used to minimize self-heating effect.

9. Guaranteed by design. Not subject to product testing.

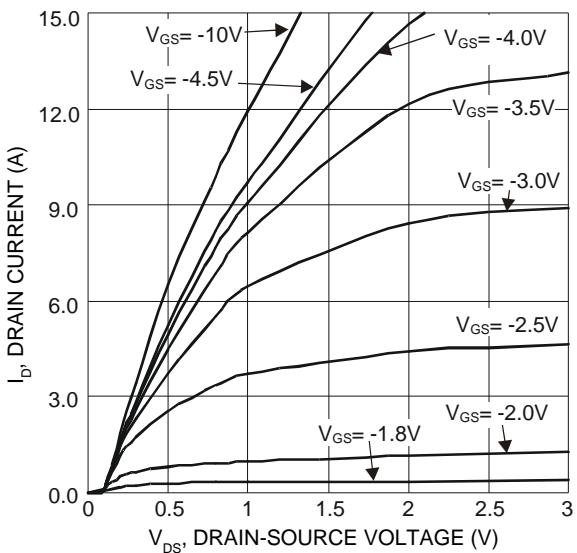


Figure 1. Typical Output Characteristic

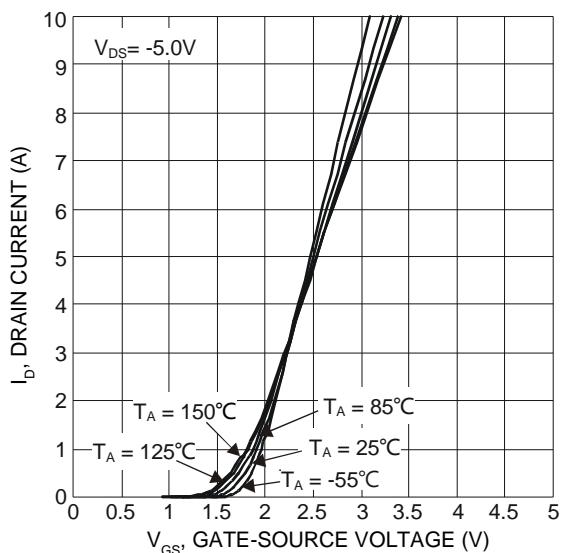


Figure 2. Typical Transfer Characteristic

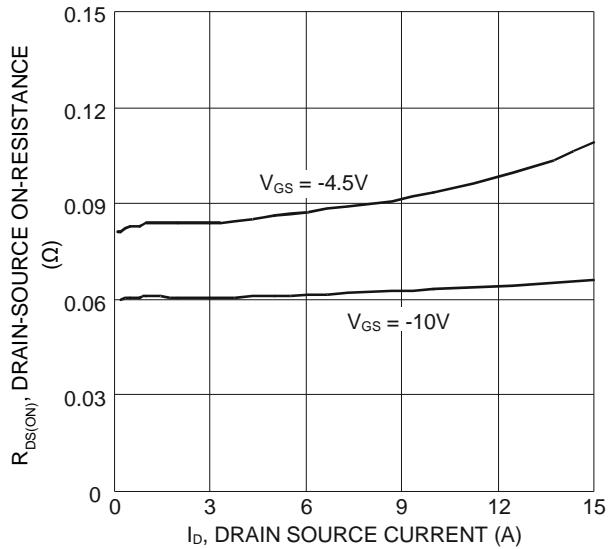


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

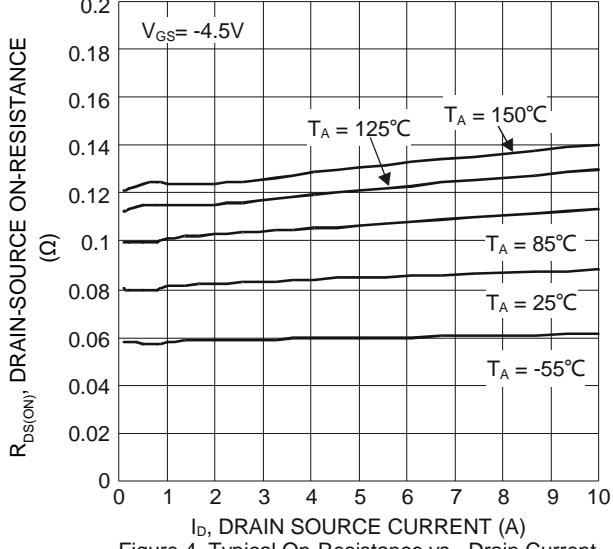


Figure 4. Typical On-Resistance vs. Drain Current and Temperature

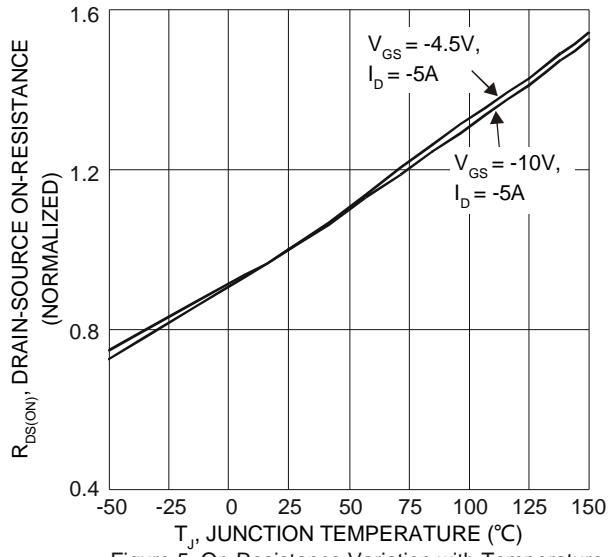


Figure 5. On-Resistance Variation with Temperature

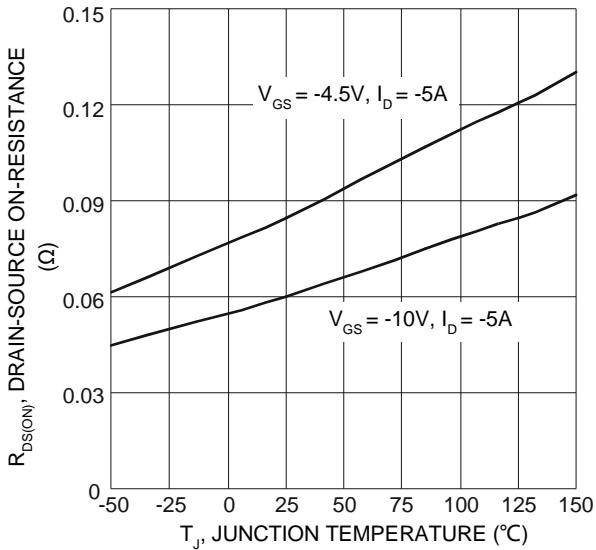


Figure 6. On-Resistance Variation with Temperature

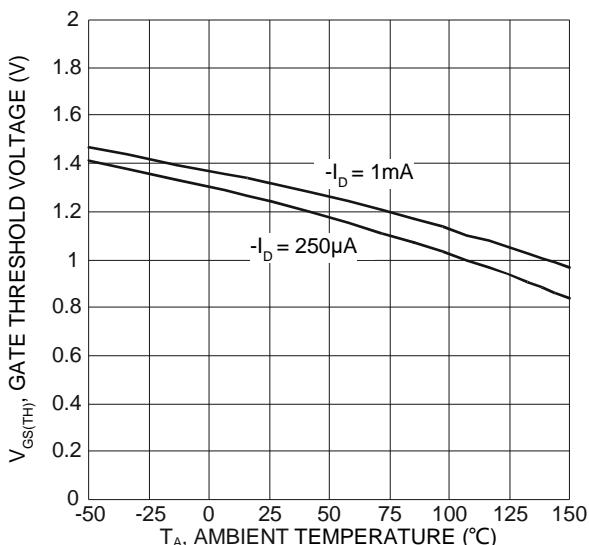


Figure 7. Gate Threshold Variation vs. Ambient Temperature

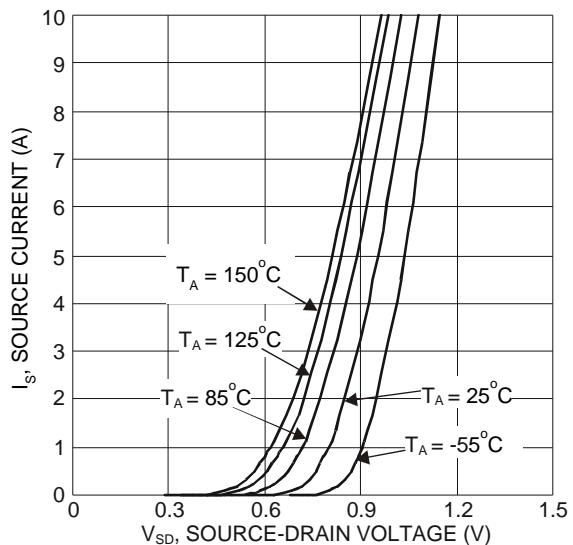


Figure 8. Diode Forward Voltage vs. Current

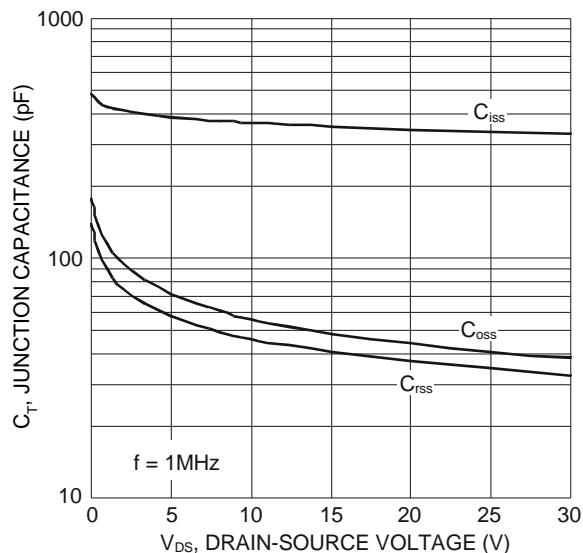


Figure 9. Typical Junction Capacitance

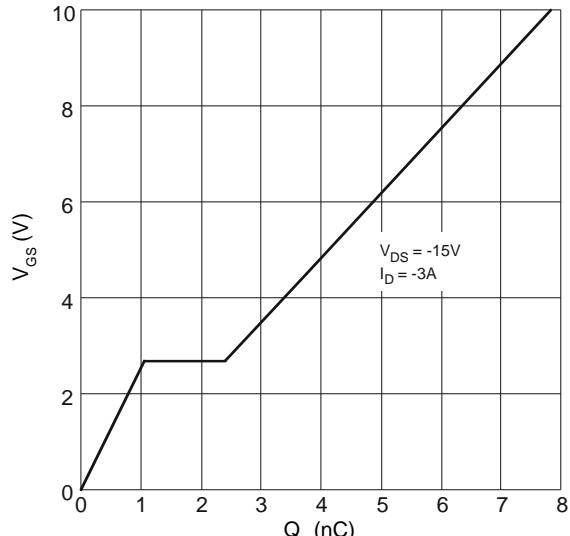


Figure 10. Gate-Charge Characteristics

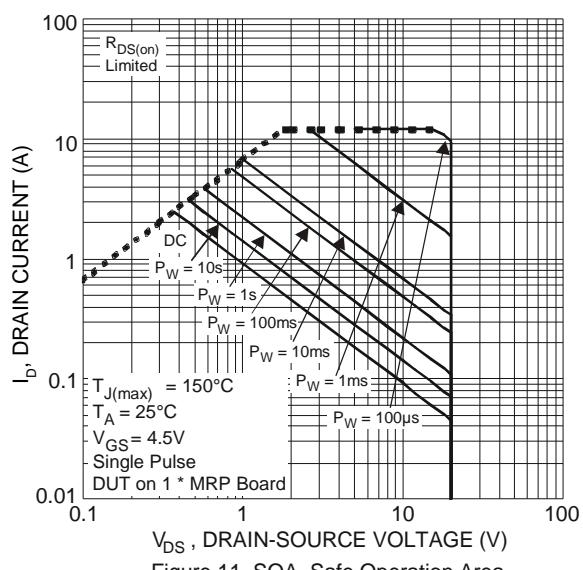
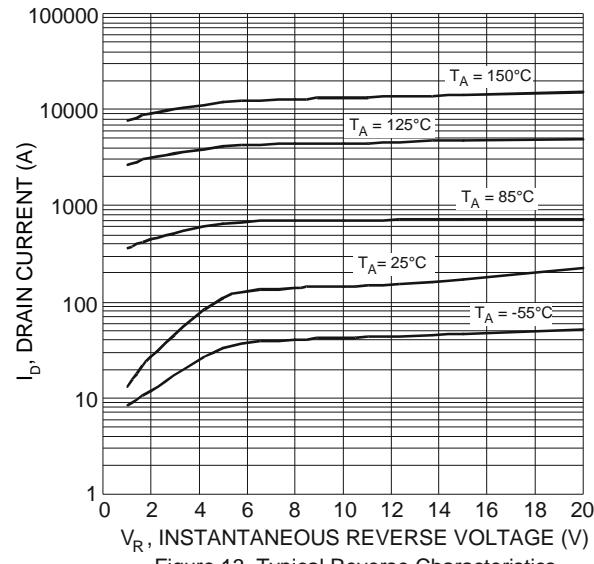
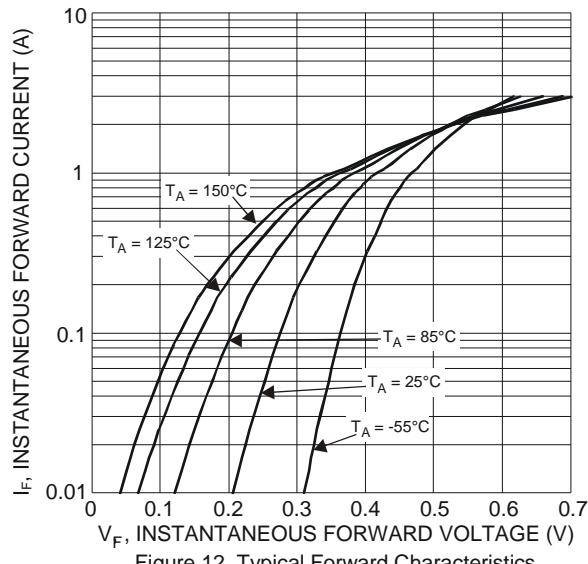


Figure 11. SOA, Safe Operation Area

Electrical Characteristics – SCHOTTKY – D1 (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

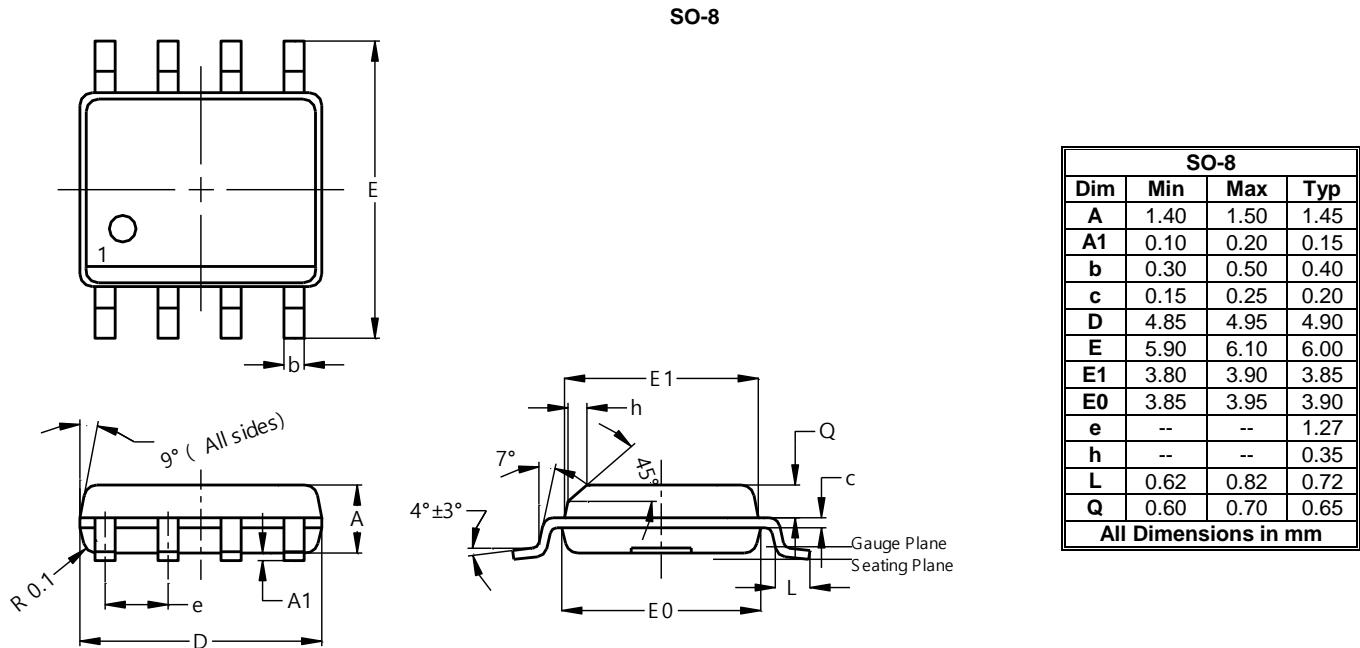
Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
Reverse Breakdown Voltage (Note 10)	$V_{(\text{BR})R}$	20	35	—	V	$I_R = 1\text{mA}$
Forward Voltage (Note 10)	V_F	—	—	0.40 0.47	V	$I_F = 0.5\text{A}$ $I_F = 1.0\text{A}$
Reverse Current (Note 10)	I_R	—	30	80	μA	$V_R = 20\text{V}$

Note: 10. Short duration pulse test used to minimize self-heating effect.



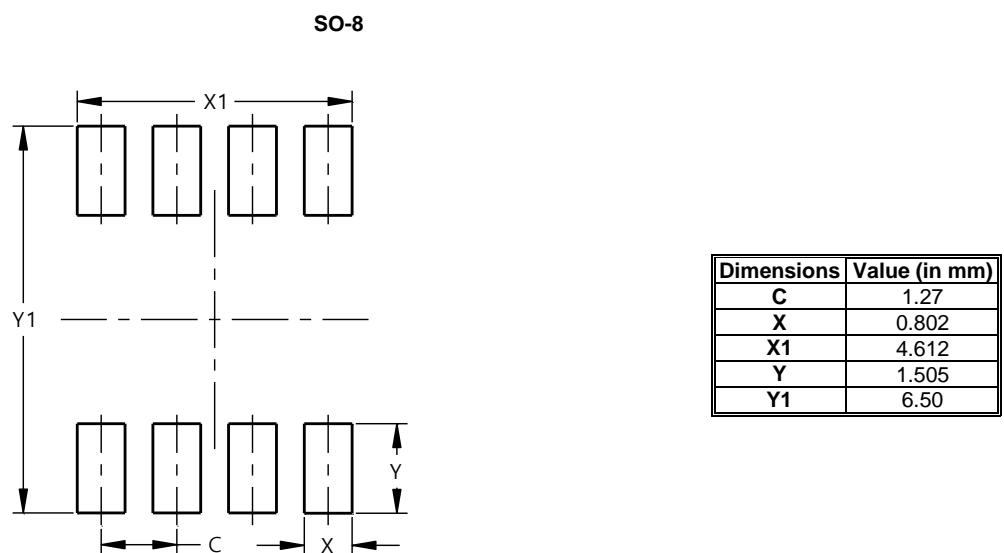
Package Outline Dimensions

Please see <http://www.diodes.com/package-outlines.html> for the latest version.



Suggested Pad Layout

Please see <http://www.diodes.com/package-outlines.html> for the latest version.



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